**D OR P PACKAGE** 

(TOP VIEW)

8 Vcc

7

6

5

REF

GND

CT

3

RESIN

SLVS028E - APRIL 1983 - REVISED JULY 1999

SENSE

RESET

RESET

- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- Wide Supply-Voltage Range
- Precision Voltage Sensor
- Temperature-Compensated Voltage Reference
- True and Complement Reset Outputs
- Externally Adjustable Pulse Duration

#### description

The TL77xxA family of integrated-circuit supply-voltage supervisors is specifically designed for use as reset controllers in microcomputer and microprocessor systems. The supply-voltage supervisor monitors the supply for undervoltage conditions at the SENSE input. During power up, the RESET output becomes active (low) when V<sub>CC</sub> attains a value approaching 3.6 V. At this point (assuming that SENSE is above V<sub>IT+</sub>), the delay timer function activates a time delay, after which outputs RESET and RESET go inactive (high and low, respectively). When an undervoltage condition occurs during normal operation, outputs RESET and RESET go active. To ensure that a complete reset occurs, the reset outputs remain active for a time delay after the voltage at the SENSE input exceeds the positive-going threshold value. The time delay is determined by the value of the external capacitor C<sub>T</sub>: t<sub>d</sub> =  $1.3 \times 10^4 \times C_T$ , where C<sub>T</sub> is in farads (F) and t<sub>d</sub> is in seconds (s).

During power down (assuming that SENSE is below  $V_{IT-}$ ), the outputs remain active until the  $V_{CC}$  falls below a maximum of 2 V. After this, the outputs are undefined.

An external capacitor (typically 0.1  $\mu$ F for the TL77xxAC and TL77xxAI) must be connected to REF to reduce the influence of fast transients in the supply voltage.

The TL77xxAC series is characterized for operation from 0°C to 70°C. The TL77xxAI series is characterized for operation from –40°C to 85°C.

AVAILABLE OPTIONS								
	PACKAGEI	PACKAGED DEVICES						
TA	SMALL PLASTIC OUTLINE DIP (D) (P)		CHIP FORM (Y)					
0°C to 70°C TL7702ACD TL7705ACD TL7709ACD TL7712ACD TL7715ACD		TL7702ACP TL7705ACP TL7709ACP TL7712ACP TL7715ACP	TL7702ACY TL7705ACY TL7709ACY TL7712ACY TL7715ACY					
-40°C to 85°C TL7702AID TL7705AID TL7709AID TL7712AID TL7715AID		TL7702AIP TL7705AIP TL7709AIP TL7712AIP TL7715AIP						

#### AVAILABLE OPTIONS

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TL7702ACDR). Chip forms are tested at 25°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



SLVS028E – APRIL 1983 – REVISED JULY 1999

## functional block diagram

The functional block diagram is shown for illustrative purposes only; the actual circuit includes a trimming network to adjust the reference voltage and sense-comparator trip point.







SLVS028E - APRIL 1983 - REVISED JULY 1999

### absolute maximum ratings over operating free-air temperature (unless otherwise noted)<sup>†</sup>

$\label{eq:transform} \begin{array}{c} TL7709A \\ TL7712A, TL7715A \\ TL7712A, TL7715A \\ High-level output current, I_{OH}, RESET \\ Low-level output current, I_{OL}, RESET \\ Package thermal impedance, \theta_{JA} (see Notes 3 and 4): D pack \\ Dackage thermal impedance, \theta_{JA} (see Notes 3 and 4): D pack \\ Dackage thermal impedance \\ \mathsf$	-0.3 V to 20 V -0.3 V to 6 V -0.3 V to 20 V -30 mA 30 mA sage
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds Storage temperature range, T <sub>stg</sub>	1 8

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to the network ground terminal.

- 2. For proper operation of the TL7702A, the voltage applied to the SENSE terminal should not exceed V<sub>CC</sub> 1 V or 6 V, whichever is less.
- 3. Maximum power dissipation is a function of  $T_J(max)$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(max) T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can impact reliability.
- 4. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

### recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V <sub>CC</sub>		3.5	18	V
High-level input voltage at RESIN, VIH		2		V
Low-level input voltage at RESIN, VIL			0.6	V
	TL7702A	0	See Note 2	
Input voltage, SENSE, VI	TL7705A	0	10	
	TL7709A	0	15	V
	TL7712A	0	20	
	TL7715A	0	20	
High-level output current, RESET, I <sub>OH</sub>			-16	mA
Low-level output current, RESET, IOL			16	mA
Timing capacitor, CT			10	μF
	TL77xxAC	0	70	°C
Operating free-air temperature range, T <sub>A</sub>	TL77xxAI	-40	85	-0

NOTE 2: For proper operation of the TL7702A, the voltage applied to the SENSE terminal should not exceed V<sub>CC</sub> – 1 V or 6 V, whichever is less.



SLVS028E - APRIL 1983 - REVISED JULY 1999

## electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		PARAMETER TEST CONDITIONS <sup>†</sup>		TL77xxAC TL77xxAI			UNIT		
				MIN	TYP	MAX			
Vон	High-level output voltage	, RESET		I <sub>OH</sub> = -16 mA	V <sub>CC</sub> -1.5			V	
VOL	Low-level output voltage	, RESET		I <sub>OL</sub> = 16 mA			0.4	V	
Vref	Reference voltage			T <sub>A</sub> = 25°C	2.48	2.53	2.58	V	
			TL7702A		2.48	2.53	2.58		
			TL7705A	]	4.5	4.55	4.6		
$V_{IT-}$	Negative-going input three SENSE	eshold voltage,	TL7709A	$T_A = 25^{\circ}C$	7.5	7.6	7.7	V	
	TL7712A	TL7712A	1	10.6	10.8	11			
		TL7715A		13.2	13.5	13.8			
		TL7702A			10				
		F	TL7705A		15				
V <sub>hys</sub>	Hysteresis, SENSE (VIT	+ - V <sub>IT</sub> _)	TL7709A	$T_A = 25^{\circ}C$		20		mV	
	TL771:	TL7712A	]		35		I		
		TL7715A			45				
		nput current RESIN		$V_{I} = 2.4 \text{ V to } V_{CC}$			20		
lj –	Input current SENSE			V <sub>I</sub> = 0.4 V			-100	μΑ	
		TL7702A	$V_{ref} < V_I < V_{CC} - 1.5 V$		0.5	2			
IОН	High-level output current	, RESET		V <sub>O</sub> = 18 V			50	μΑ	
IOL	Low-level output current,	RESET		$V_{O} = 0$			-50	μA	
ICC	Supply current			All inputs and outputs open		1.8	3	mA	

<sup>†</sup> All electrical characteristics are measured with 0.1- $\mu$ F capacitors connected at REF, CT, and V<sub>CC</sub> to GND.

## switching characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS <sup>‡</sup>		TL77xxAC TL77xxAI			UNIT	
					MIN	TYP	MAX	
	Output pulse duration		C <sub>T</sub> = 0.1 μF		0.65	1.2	2.6	μs
	Input pulse duration at RESIN				0.4			μs
<sup>t</sup> w(S)	Pulse duration at SENSE input to switch outputs	3	$V_{IH} = V_{IT-} + 200 \text{ mV},$	$V_{IL} = V_{IT-} -200 \text{ mV}$	2			μs
<sup>t</sup> pd	Propagation delay time, RESIN to RESET		$V_{CC} = 5 V$				1	μs
	Rise time	RESET	V <sub>CC</sub> = 5 V,				0.2	
tr	Rise lime	RESET		See Note 5			3.5	μs
+	RE	RESET	ESET	Soo Noto E			3.5	
tf	Fall time	e V <sub>CC</sub> = 5 V,	See Note 5			0.2	μs	

<sup>‡</sup> All switching characteristics are measured with 0.1- $\mu$ F capacitors connected at REF and V<sub>CC</sub> to GND. NOTE 5: The rise and fall times are measured with a 4.7-k $\Omega$  load resistor at RESET and RESET.



SLVS028E - APRIL 1983 - REVISED JULY 1999

# electrical characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

PARAMETER			TL77xxAY			UNIT	
	PARAMETER		TEST CONDITIONS <sup>†</sup>	MIN	TYP	MAX	UNIT
Vref	Reference voltage				2.53		V
		TL7702A			2.53		
		TL7705A			4.55		
V <sub>IT</sub>	Negative-going input threshold voltage, SENSE	TL7709A	1		7.6		V
		TL7712A			10.8		
		TL7715A	1		13.5		
		TL7702A			10		
		TL7705A	1		15		
V <sub>hys</sub>	Hysteresis, SENSE (V <sub>IT+</sub> – V <sub>IT</sub> –)	TL7709A	1		20		mV
		TL7712A	1		35		
		TL7715A	1		45		
Ц	Input current, SENSE	TL7702A	$V_{ref} < V_{I} < V_{CC} - 1.5 V$		0.5		μA
ICC	Supply current		All inputs and outputs open		1.8		mA

<sup>†</sup> All electrical characteristics are measured with 0.1- $\mu$ F capacitors connected at REF, CT, and V<sub>CC</sub> to GND.

# switching characteristics over recommended operating conditions, $T_{A}$ = 25°C (unless otherwise noted)

PARAMETER	TEST CONDITIONS <sup>‡</sup>	TL77xxAY			UNIT	
		MIN	TYP	MAX	UNIT	
td	Output pulse time delay	C <sub>T</sub> = 0.1 μF		1.2		μs

<sup>‡</sup> All switching characteristics are measured with  $0.1-\mu$ F capacitors connected at REF and V<sub>CC</sub> to GND.



SLVS028E - APRIL 1983 - REVISED JULY 1999







SLVS028E - APRIL 1983 - REVISED JULY 1999

## **TYPICAL CHARACTERISTICS<sup>†</sup>**



<sup>†</sup> For proper operation, both RESET and RESET should be terminated with resistors of similar value. Failure to do so may cause unwanted plateauing in either output waveform during switching.



SLVS028E – APRIL 1983 – REVISED JULY 1999







Figure 7. Reset Controller for TMS7000 System



SLVS028E - APRIL 1983 - REVISED JULY 1999



Figure 8. Eliminating Undefined States Using a P-Channel JFET



Figure 9. Eliminating Undefined States Using a pnp Transistor



#### **IMPORTANT NOTICE**

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1999, Texas Instruments Incorporated